



EMC TEST REPORT

Equipment	Power adapter
Trademark	N/A
Model No.	See "General Information" on page 5 to 6
Applicant	Shenzhen Anthy Electronics Co., Ltd. 401, Building E, Longtianli Industrial Park, No.11 Zhangyi Road, Zhang Ge Community, Fucheng subdistrict, Longhua District, 518110, Shenzhen, PEOPLE'S REPUBLIC OF CHINA
Manufacturer	Sichuan Anthy Electronics Co., Ltd. 4/F, Building 3, Intellective Manufacturing Garden (First-stage), South of Qihe Road, Economic Development Area, 635000 Dazhou, Sichuan, PEOPLE'S REPUBLIC OF CHINA
Prepared by	Shenzhen An-Teng Testing Service Co., Ltd. Floor 5, No. 11, Hebei Industrial Zone, Hualian Community, Longhua Street, Longhua District, Shenzhen, China.
Report No.	ATJC24032080003400E
Date of Test	Mar. 20 – Mar. 25, 2024
Date of Issue	April 23, 2024
Test Standard(s)	EN 55032:2015+A1:2020, EN 55035:2017+A11:2020 EN IEC 61000-3-2:2019+A1:2021, EN 61000-3-3:2013+A2:2021

In the configuration tested, the EUT complied with the standards specified above.

Tested	:  Cris Song / Engineer	Date	: April 23, 2024
Approved	:  Henry Tian / Manager	Date	: April 23, 2024

Note:

The results shown in this test report refer only to the sample(s) tested unless otherwise stated. This test report shall not be reproduced except in full, without prior written approval of ATJC. This document may be altered or revised by ATJC personnel only, and shall be noted in the revision of the document.

Shenzhen An-Teng Testing Service Co., Ltd.

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Revision History

Rev.	Issue Date	Revisions	Effect Page	Revised By
0	April 23, 2024	Initial Issue	All Page	Cris Song

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1. TEST SUMMARY

Emission			
Requirement - Test	Test Method	Limit	Result
Conducted Emission	EN 55032:2015+A1:2020	Class B	PASS
Radiated emissions at frequencies up to 1 GHz		Class B	PASS
Radiated emissions at frequencies above 1 GHz		Class B	N/A
Harmonic current emissions	EN IEC 61000-3-2:2019+A1:2021	Class A	PASS
Voltage changes, voltage fluctuations and flicker	EN 61000-3-3:2013+A2:2021	Clause 5	PASS
Immunity (EN 55035:2017+A11:2020)			
Requirement - Test	Test Method	Performance criteria	Result
Electrostatic discharges (ESD)	EN 61000-4-2:2009	B	PASS
Electromagnetic field	EN IEC 61000-4-3:2020	A	PASS
Electrical fast transients/burst (EFT/B)	EN 61000-4-4:2012	B	PASS
Surges	EN 61000-4-5:2014+A1:2017	B	PASS
Conducted RF	EN 61000-4-6:2014	A	PASS
Power frequency magnetic field	EN 61000-4-8:2010	A	N/A
Voltage dips and Short interruptions	EN IEC 61000-4-11:2020	B & C	PASS

Remark:

N/A is abbreviation for Not Applicable.

The test was carried out in all the test modes, only the worst data are list in report.

2. GENERAL INFORMATION

2.1. Description of EUT

Equipment	Power adapter
Trademark	N/A
Model Name	AE100-B
Serial No.	See below model list
Model Difference	Same series models have the same circuit diagram, layout, transformer and construction, except the specification of secondary components are different. Each models has two different color of enclosure: white and black, two types of plug: EU plug and BS plug.
Rated Power Supply	See below model list
Rated Power	100W Max
Normal Testing Voltage	Input: 230V/50Hz Output: 20VDC, 5A
Configuration	<input checked="" type="checkbox"/> Table-top <input type="checkbox"/> Floor-standing
Accessory Device	N/A
Cable Supplied	N/A

Note:

1. Other Accessory Device List and Details

Description	Manufacturer	Model	Note
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External I/O Cable

Cable Description	Shielded Type	Ferrite Core	Length(m)	Note
-	<input type="checkbox"/> Shielded <input type="checkbox"/> Non-shielded	<input type="checkbox"/> Yes <input type="checkbox"/> No		

2. The above EUT information is declared by manufacturer and for more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

Model list:

Model name	Input voltage	Output voltage	Output current	Output power
RXMCT-85W	200-240V~, 50/60Hz, 2A Max	20V	4.25A	85W
RXMCL-85W		18.5V	4.6A	85W
AF185460		18.5V	4.6A	85W

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AF200425	20V	4.25A	85W
AFUA09	15V-20V	MAX 5A	90W
AE85	20V	4.25A	85W
AE85-B	18.5V	4.6A	85W
AE67-B	20V	3.35A	67W
AE65-B	20V	3.25A	65W
AE61-B	20V	3.05A	61W
AE60	16.5V	3.65A	60W
AE45-B	14.85V	3.05A	45W
AE45-B1	14.5V	3.1A	45W
A85-B	18.5V	4.6A	85W
A85	20V	4.25A	85W
A67	20V	3.35A	67W
A65	20V	3.25A	65W
A61	20V	3.05A	61W
A60	16.5V	3.65A	60W
A45	14.85V	3.05A	45W
A45-B	14.5V	3.1A	45W
AE100-B	5V-20V	MAX 5A	100W
AE96-B	5V-20V	MAX 4.8A	96W
AE90-B	5V-20V	MAX 4.5A	90W
AE87-B	5V-20V	MAX 4.35A	87W
AE67-B	5V-20V	MAX 3.35A	67W
AE65-B	5V-20V	MAX 3.25A	65W
AE61-B	5V-20V	MAX 3.05A	61W
AE45-B	5V-20V	2.25A	45W
AF100-B	5V-20V	MAX 5A	100W
AF96-B	5V-20V	MAX 4.8A	96W
AF90-B	5V-20V	MAX 4.5A	90W
AF87-B	5V-20V	MAX 4.35A	87W
AF67-B	5V-20V	MAX 3.35A	67W
AF65-B	5V-20V	MAX 3.25A	65W
AF61-B	5V-20V	MAX 3.05A	61W
AF45-B	5V-20V	2.25A	45W
AFxxxxyy	5V-20V	0.00A-5.00A	100W Max
AFxxxxyy: "xxx" represent output voltage, can be 500 to 200, 500 means 5.00V, etc.; "yyy" represent output current, can be 001 to 500, 0.01 means 0.01A, etc.			

2.2. Operating Condition of EUT

Test mode	Description
1	Working
2	

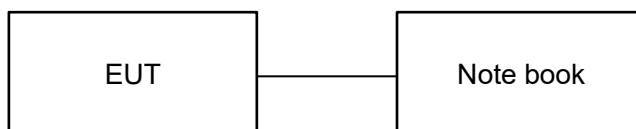
2.3. Test Conditions

Temperature: 15-35℃

Relative Humidity: 30-60 %

Atmospheric pressure: 800hPa-1060hPa

2.4. Block Diagram of EUT Configuration



3. FACILITIES

3.1. Test Facility

ATJC-LAB

Floor 5, No. 11, Hebei Industrial Zone, Hualian Community, Longhua Street, Longhua District, Shenzhen, China.

3.2. Test Instruments

Radiated Emission Measurement (Test software: EZ-EMC Ver. FA-03A2 RE)

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until
1	Double Ridged Broadband Horn Antenna	Schwarzbeck	BBHA 9120D	1911	2024-10-30
2	TRILOG Broadband Antenna	Schwarzbeck	VULB 9168	869	2024-10-30
3	Amplifier	Agilent	8449B	3008A01838	2024-10-30
4	Amplifier	HP	8447E	2945A02747	2024-10-30
5	EMI TEST RECEIVER	ROHDE&SCHWARZ	ESPI7	100362	2024-10-30
6	Coaxial cable	ETS	RFC-SNS-100 -NMS-80 NI	/	2024-10-30
7	Coaxial cable	ETS	RFC-SNS-100 -NMS-20 NI	/	2024-10-30
8	Coaxial cable	ETS	RFC-SNS-100 -SMS-20 NI	/	2024-10-30
9	Coaxial cable	ETS	RFC-NNS-10 0-NMS-300 NI	/	2024-10-30

Electrostatic Discharge Test

Item	Equipment	Manufacturer	Model No.	Serial No.	Calibrated until
1	ESD Simulator	TESTQ	NSG437	329	2024-10-30

RF electromagnetic field Test

Item	Equipment	Manufacturer	Type No.	Serial No.	Calibrated until
1	Signal Generator	Agilent	N5182A	MY47420195	2024-10-30
2	Log-Bicon Antenna	Schwarzbeck	VULB9161	9128ES-128	2024-10-30
3	Power Amplifier	AR	150W1000M1	342526	2024-10-30
4	Microwave Horn Antenna	AR	AT4002A	322279	2024-10-30
5	Power Amplifier	AR	25S1G4A	321116	2024-10-30

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4. Measurement Uncertainty

The following table is for the measurement uncertainty, which is calculated as per the document CISPR 16-4.

Test	Parameters	Expanded Uncertainty (U_{Lab})	Expanded Uncertainty (U_{Cispr})
Conducted Emission	Level Accuracy: 150kHz to 30MHz	± 1.22 dB	± 3.6 dB
Radiated Emission	Level Accuracy: 30MHz to 1000 MHz	± 3.67 dB	± 5.2 dB
Radiated Emission	Level Accuracy: Above 1000MHz	± 4.79 dB	N/A

This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=2$.

5. Emission

5.1. Conducted Emission

5.1.1. Limit

Requirements for conducted emissions from the AC mains power ports of Class A equipment

Frequency range MHz	Coupling device	Detector type / bandwidth	Class A limits dB(μV)
0,15 to 0,5	AMN	Quasi Peak / 9 kHz	79
0,5 to 30			73
0,15 to 0,5		Average / 9 kHz	66
0,5 to 30			60

Requirements for conducted emissions from the AC mains power ports of Class B equipment

Frequency range MHz	Coupling device	Detector type / bandwidth	Class B limits dB(μV)
0,15 to 0,5	AMN	Quasi Peak / 9 kHz	66 to 56
0,5 to 5			56
5 to 30			60
0,15 to 0,5		Average / 9 kHz	56 to 46
0,5 to 5			46
5 to 30			50

Requirements for asymmetric mode conducted emissions from Class A equipment

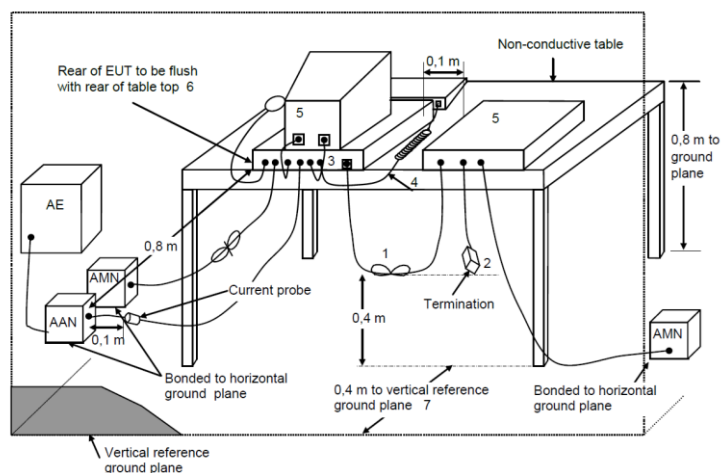
Frequency range MHz	Coupling device	Detector type / bandwidth	Class A limits dB(μV)
0,15 to 0,5	AAN	Quasi Peak / 9 kHz	97 to 87
0,5 to 30			87
0,15 to 0,5		Average / 9 kHz	84 to 74
0,5 to 30			74

Requirements for asymmetric mode conducted emissions from Class B equipment

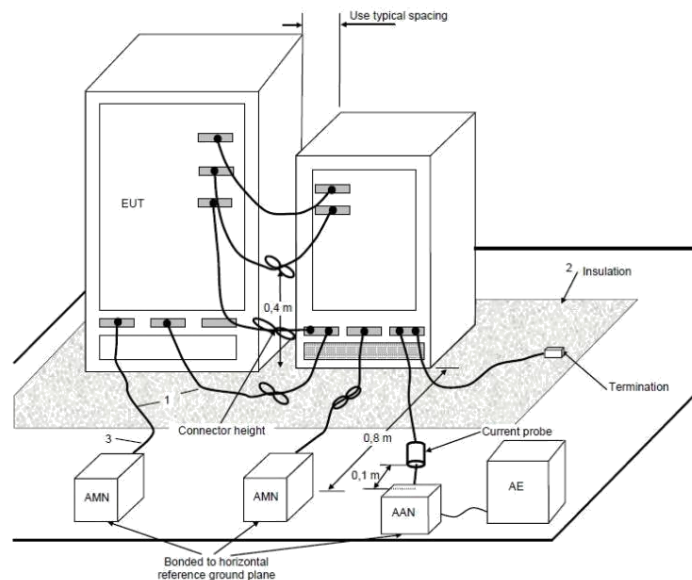
Frequency range MHz	Coupling device	Detector type / bandwidth	Class B limits dB(μV)
0,15 to 0,5	AAN	Quasi Peak / 9 kHz	84 to 74
0,5 to 30			74
0,15 to 0,5		Average / 9 kHz	74 to 64
0,5 to 30			64

5.1.2. Test Setup

For table-top equipment



For floor standing equipment



5.1.3. Test Procedure

Measurement was performed in shielded room, and instruments used were followed CISPR 16-2-1 clause7.

Detailed test procedure was following clause 7 of CISPR 16-2-1.

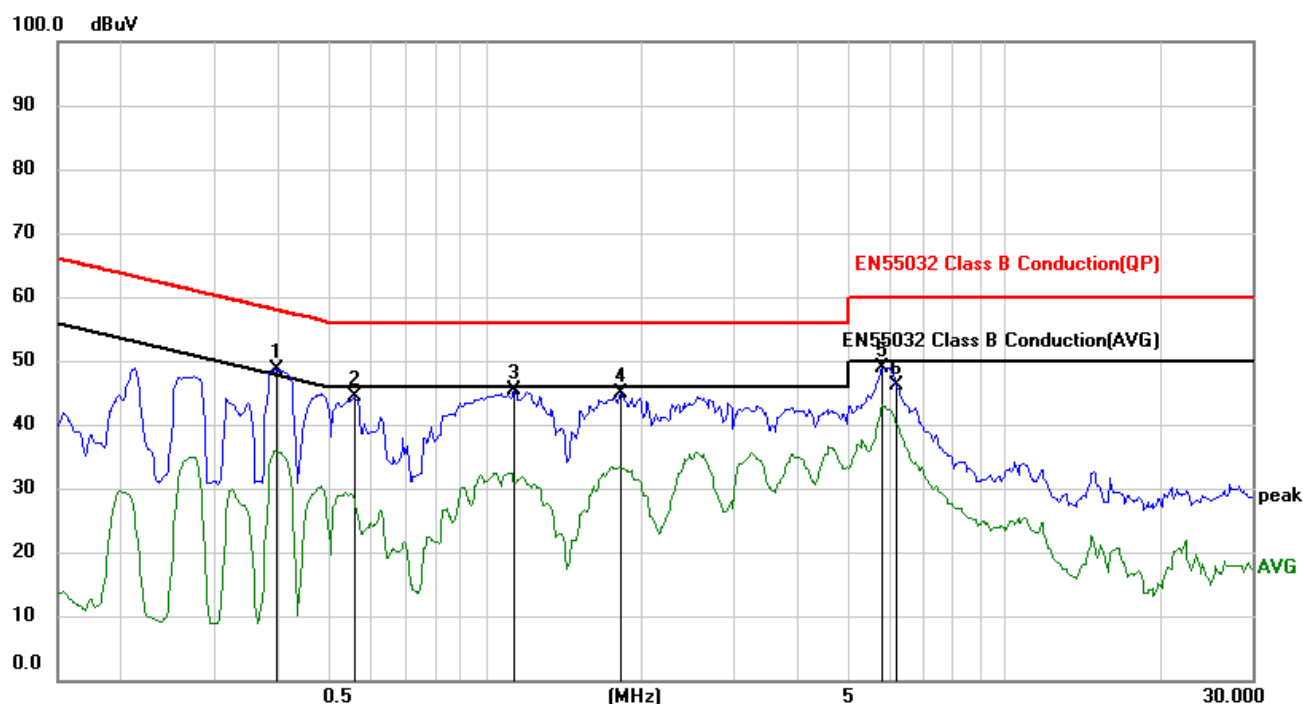
Frequency range 150kHz – 30MHz was checked and EMI receiver measurement bandwidth was set to 9 kHz.

5.1.4. Test Results

PASS

Please refer to the following page.

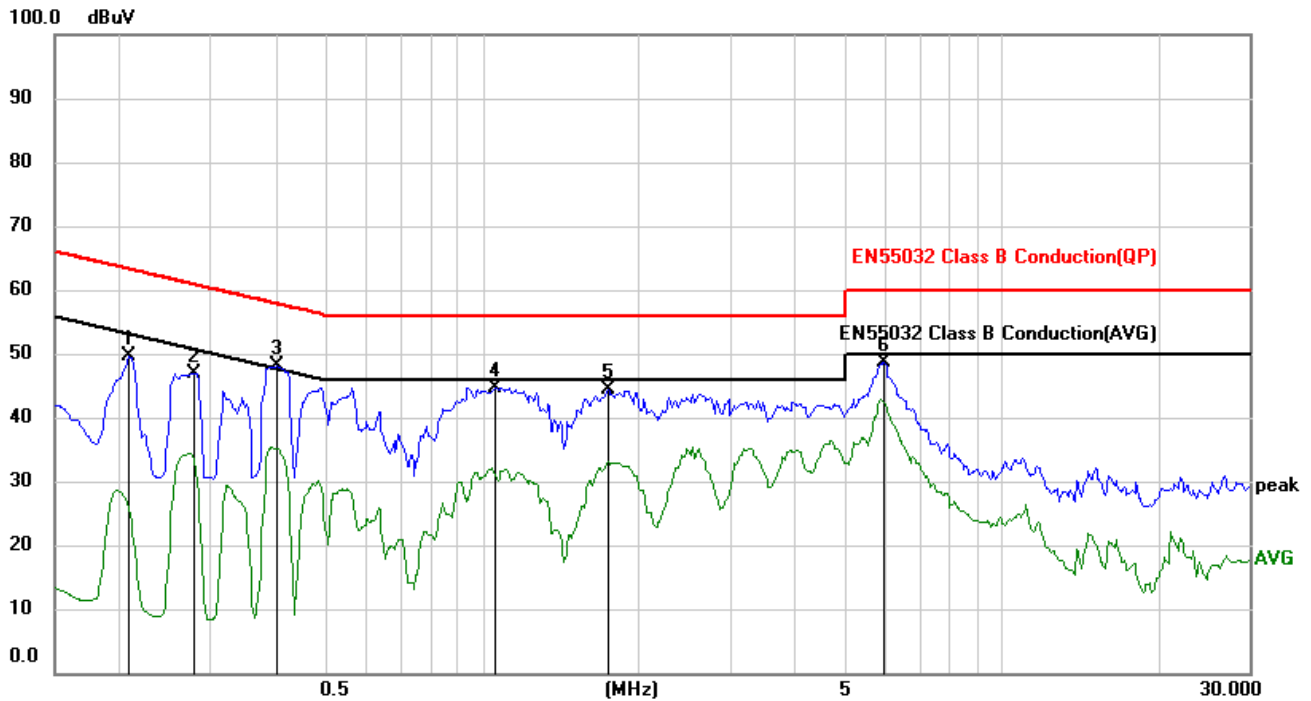
Phase: L



No.	Mk.	Freq.	Reading	Correct	Measure-	Limit	Over	
		MHz	Level	Factor	ment			Detector
			dBuV	dB	dBuV	dBuV	dB	
1	*	0.3957	38.16	10.43	48.59	57.94	-9.35	peak
2		0.5595	33.74	10.54	44.28	56.00	-11.72	peak
3		1.1406	34.41	10.89	45.30	56.00	-10.70	peak
4		1.8192	33.97	10.84	44.81	56.00	-11.19	peak
5		5.8158	37.77	11.21	48.98	60.00	-11.02	peak
6		6.1860	34.73	11.28	46.01	60.00	-13.99	peak

Note: Result=Reading+Factor
Over Limit=Result-Limit

Phase: N



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV	Limit dBuV	Over dB	Detector
1		0.2085	39.40	10.20	49.60	63.26	-13.66	peak
2		0.2787	36.66	10.24	46.90	60.85	-13.95	peak
3	*	0.4035	37.73	10.30	48.03	57.78	-9.75	peak
4		1.0587	33.85	10.80	44.65	56.00	-11.35	peak
5		1.7451	33.64	10.82	44.46	56.00	-11.54	peak
6		5.9367	37.70	10.91	48.61	60.00	-11.39	peak

Note: Result=Reading+Factor
Over Limit=Result-Limit

5.2. Radiated emissions

5.2.1. Limit

Requirements for radiated emissions at frequencies up to 1 GHz for class A equipment

Frequency range MHz	Measurement			Class B limits dB(μV/m)
	Facility	Distance m	Detector type / bandwidth	
30 to 230	SAC	3	Quasi Peak / 120 kHz	50
230 to 1 000				57

Requirements for radiated emissions at frequencies above 1 GHz for class A equipment

Frequency range MHz	Measurement			Class B limits dB(μV/m)
	Facility	Distance m	Detector type / bandwidth	
1 000 to 3 000	FSOATS	3	Average / 1MHz	56
3 000 to 6 000				60
1 000 to 3 000		3	Average / 1MHz	76
3 000 to 6 000				80

Requirements for radiated emissions at frequencies up to 1 GHz for class B equipment

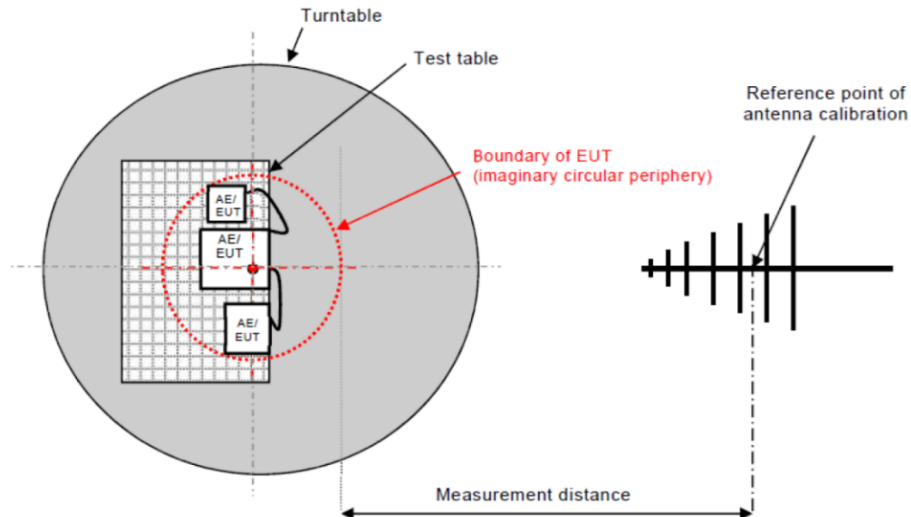
Frequency range MHz	Measurement			Class B limits dB(μV/m)
	Facility	Distance m	Detector type / bandwidth	
30 to 230	SAC	3	Quasi Peak / 120 kHz	40
230 to 1 000				47

Requirements for radiated emissions at frequencies above 1 GHz for class B equipment

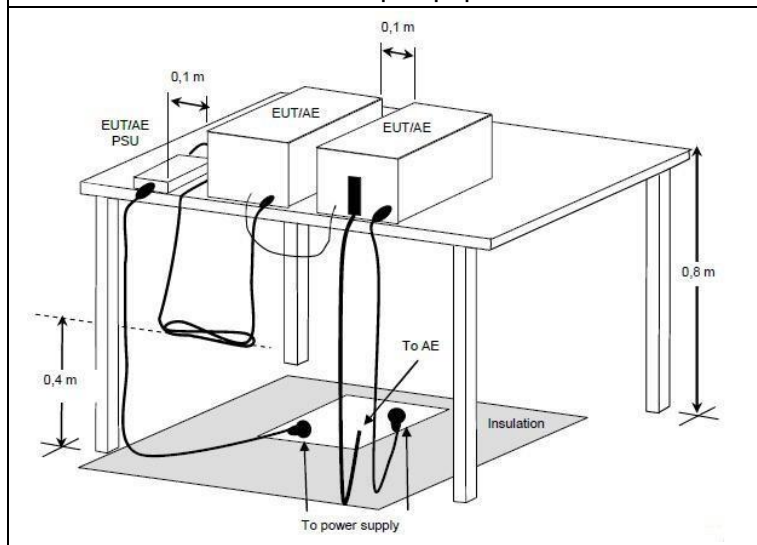
Frequency range MHz	Measurement			Class B limits dB(μV/m)
	Facility	Distance m	Detector type / bandwidth	
1 000 to 3 000	FSOATS	3	Average / 1MHz	50
3 000 to 6 000				54
1 000 to 3 000		3	Average / 1MHz	70
3 000 to 6 000				74

5.2.2. Block Diagram of Test Setup

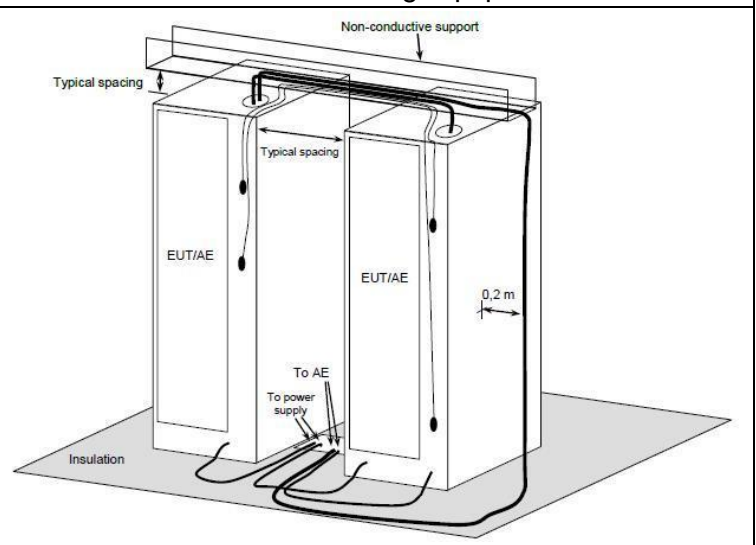
Measurement distance



For table-top equipment



For floor standing equipment



5.2.3. Test Procedure

The measurement was performed in a semi-anechoic chamber.

The distance from EUT to receiving antenna is 3 meters.

Measurement was performed according to clause 7.3 of CISPR 16-2-3.

5.2.4. Test Results

PASS

Please refer to the following page.

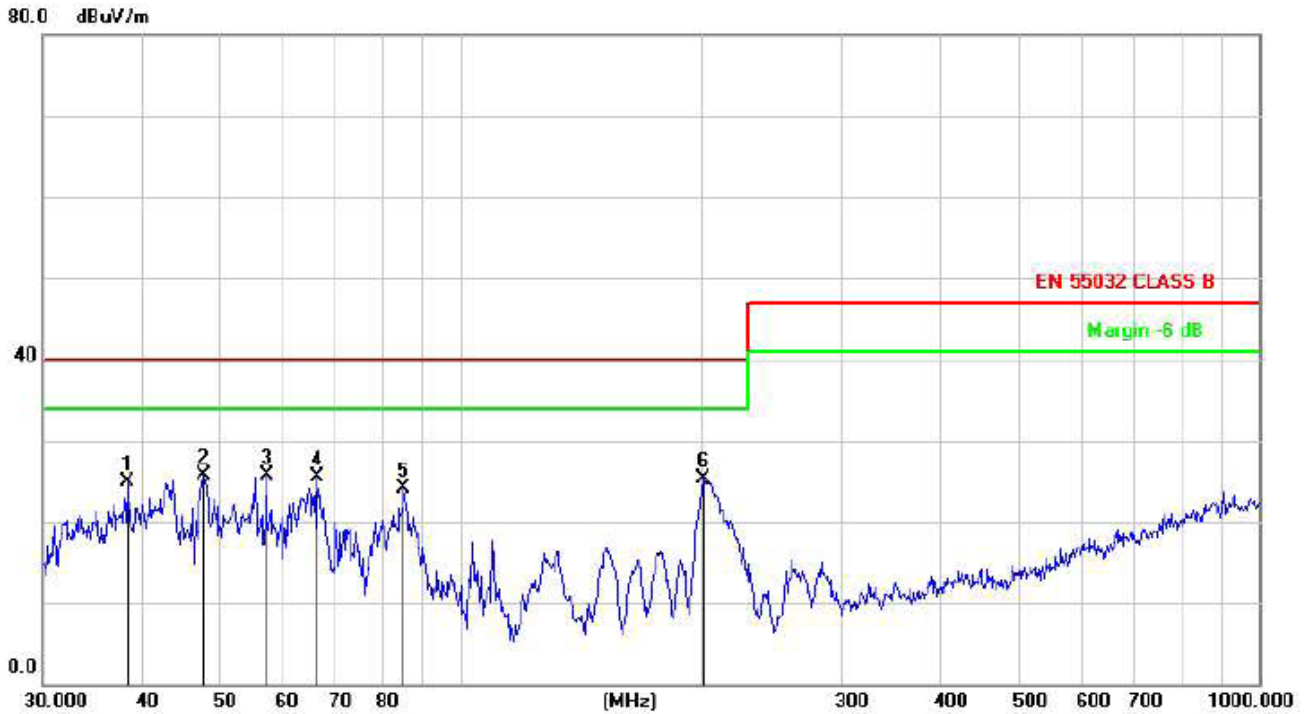
Polarization: H



No.	Mk.	Freq. MHz	Reading Level dBuV	Correct Factor dB	Measure- ment dBuV/m	Limit dB/m	Over dB	Detector
1	*	67.6751	48.45	-19.54	28.91	40.00	-11.09	peak
2		84.9995	42.35	-21.96	20.39	40.00	-19.61	peak
3		164.9075	41.20	-18.31	22.89	40.00	-17.11	peak
4		207.8501	38.59	-20.53	18.06	40.00	-21.94	peak
5		392.0951	29.60	-15.43	14.17	47.00	-32.83	peak
6		625.0780	35.73	-10.10	25.63	47.00	-21.37	peak

Note: Result=Reading+Factor
Over Limit=Result-Limit

Polarization: V



No.	Mk.	Freq.	Reading	Correct	Measure-	Limit	Over	
		MHz	Level	Factor	ment			Detector
			dBuV	dB	dBuV/m	dB/m	dB	
1		38.3462	42.51	-17.65	24.86	40.00	-15.14	peak
2		47.8260	42.99	-17.29	25.70	40.00	-14.30	peak
3	*	57.1914	43.59	-17.87	25.72	40.00	-14.28	peak
4		66.2662	44.81	-19.28	25.53	40.00	-14.47	peak
5		84.9995	46.14	-21.96	24.18	40.00	-15.82	peak
6		201.3930	46.13	-20.91	25.22	40.00	-14.78	peak

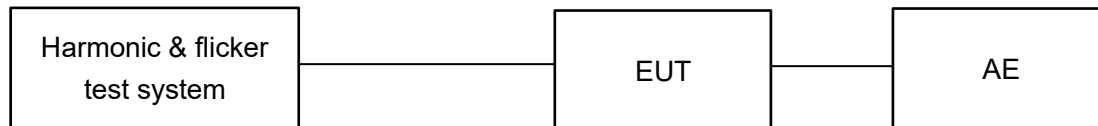
Note: Result=Reading+Factor
Over Limit=Result-Limit

5.3. Harmonic current emissions

5.3.1. Test Specifications

Basic Standard(s)	:	EN IEC 61000-3-2:2019+A1:2021
Measurement Equipment requirement	:	IEC 61000-4-7
Measured Harmonics	:	1 - 40
Equipment Class	:	<input checked="" type="checkbox"/> A <input type="checkbox"/> B <input type="checkbox"/> C <input type="checkbox"/> D
Limits	:	<input checked="" type="checkbox"/> Clause 7.2 & Table 1 <input type="checkbox"/> Clause 7.3 & Table 1 <input type="checkbox"/> Clause 7.5 & Table 3

5.3.2. Test Setup



5.3.3. Test Procedure

Harmonics of the fundamental current were measured up to 40 order harmonics using a digital power meter with an analogue output and frequency analyzer which was integrated in the harmonic & flicker test system. The measurements were carried out under steady conditions.

- ☒ Active input power > 25 W
- ☐ Active input power ≤ 25 W

5.3.4. Test Results

PASS

Please refer to the following page.

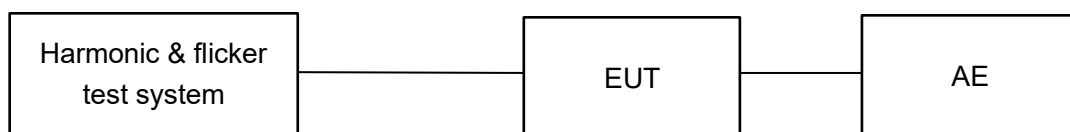
Fundamental I :		373.1				
2 :	1080.0	1.6	0.1	3.6	0.3	Pass
3 :	2300.0	352.6	15.3	354.6	15.4	Pass
4 :	430.0	1.8	0.4	3.4	0.8	Pass
5 :	1140.0	323.6	28.4	324.7	28.5	Pass
6 :	300.0	2.0	0.7	3.0	1.0	Pass
7 :	770.0	283.7	36.8	284.1	36.9	Pass
8 :	230.0	2.0	0.9	2.6	1.1	Pass
9 :	400.0	236.4	59.1	237.1	59.3	Pass
10 :	184.0	1.9	1.0	2.4	1.3	Pass
11 :	330.0	186.2	56.4	187.5	56.8	Pass
12 :	153.3	1.8	1.2	2.1	1.4	Pass
13 :	210.0	137.3	65.4	139.2	66.3	Pass
14 :	131.4	1.5	1.1	1.8	1.4	Pass
15 :	150.0	94.1	62.7	96.1	64.1	Pass
16 :	115.0	1.2	1.0	1.6	1.4	Pass
17 :	132.3	60.7	45.9	62.3	47.1	Pass
18 :	102.2	1.0	1.0	1.4	1.4	Pass
19 :	118.4	41.1	34.7	41.8	35.3	Pass
20 :	92.0	0.8	0.9	1.3	1.4	Pass
21 :	107.1	35.4	33.1	35.7	33.3	Pass
22 :	83.6	0.7	0.8	1.1	1.3	Pass
23 :	97.8	35.3	36.1	35.7	36.5	Pass
24 :	76.7	0.6	0.8	1.0	1.3	Pass
25 :	90.0	33.4	37.1	33.5	37.2	Pass
26 :	70.8	0.6	0.8	0.9	1.3	Pass
27 :	83.3	28.2	33.9	28.5	34.2	Pass
28 :	65.7	0.6	0.9	0.8	1.2	Pass
29 :	77.6	20.9	26.9	21.4	27.6	Pass
30 :	61.3	0.5	0.8	0.6	1.0	Pass
31 :	72.6	13.3	18.3	13.9	19.1	Pass
32 :	57.5	0.4	0.7	0.5	0.9	Pass
33 :	68.2	8.4	12.3	8.6	12.6	Pass
34 :	54.1	0.3	0.6	0.5	0.9	Pass
35 :	64.3	8.4	13.1	8.9	13.8	Pass
36 :	51.1	0.3	0.6	0.5	1.0	Pass
37 :	60.8	9.9	16.3	10.3	16.9	Pass
38 :	48.4	0.3	0.6	0.5	1.0	Pass
39 :	57.7	10.1	17.5	10.2	17.7	Pass
40 :	46.0	0.3	0.7	0.4	0.9	Pass
21 - 39 :	251.4	73.2	29.1	73.6	29.3	-

5.4. Voltage changes, voltage fluctuations and flicker

5.4.1. Test Specifications

Basic Standard(s)	:	EN 61000-3-3:2013+A2:2021
Measurement Equipment requirement	:	IEC 61000-4-15
Limits	:	Clause 5

5.4.2. Test Setup



4.4.2.1. Definition

Flicker: impression of unsteadiness of visual sensation induced by a lighting stimulus whose luminance or spectral distribution fluctuates with time.

P_{st} : Short-term flicker indicator the flicker severity evaluated over a short period (in minutes);

$P_{st}=1$ is the conventional threshold of irritability

P_{lt} : long-term flicker indicator; the flicker severity evaluated over a long period (a few hours) using successive P_{st} values.

dc: the relative steady-state voltage change

d_{max} : the maximum relative voltage change

$d(t)$: the value during a voltage change

4.4.2.2. Test Procedure

The following limits apply

- " P_{lt} " shall not exceed 0.65.
- " P_{st} " shall not exceed 1.0.
- "dc" shall not exceed 3.3%.
- " $d(t)$ " shall not exceed 3.3% for more than 500ms.
- " d_{max} " shall not exceed:
 - ☐ 4% without additional conditions,
 - ☐ 6% switched manually or automatically more than twice per day,
 - ☐ 7% attended whilst in use or switched automatically for no more than twice per day or attended while in use.
 - ☐ For manual switch, d_{max} is measured in accordance with Annex B of standard, average d_{max} is calculated from 24 times measurement.
 - ☒ The EUT is unlikely to produce significant voltage fluctuations or flicker by technical analysis and evaluation. So it is deemed to fulfil the requirements without testing.

5.4.3. Test Results

N/A

6. Immunity

Performance criteria

Performance criterion **A**

The equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a performance level specified by the manufacturer when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion **B**

After the test, the equipment shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the equipment is used as intended. The performance level may be replaced by a permissible loss of performance.

During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test. If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the equipment if used as intended.

Performance criterion **C**

Loss of function is allowed, provided the function is self-recoverable, or can be restored by the operation of the controls by the user in accordance with the manufacturer's instructions. Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

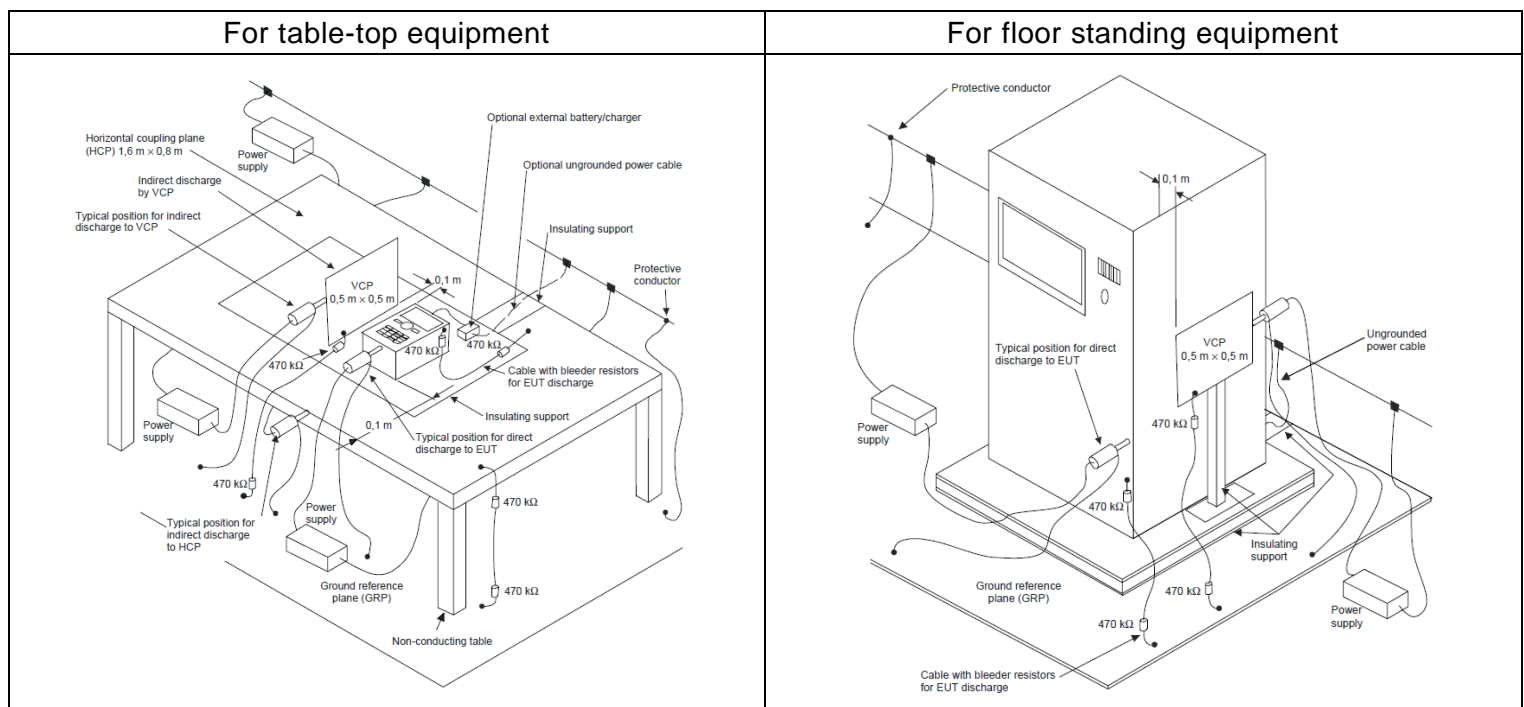
6.1. Electrostatic discharge

6.1.1. Test Levels and Performance Criterion

Characteristics	Test levels
Air discharge	± 8 kV
Contact discharge	± 4 kV

Performance criterion: **B**

6.1.2. Test Setup



6.1.3. Test Procedure

Measurement was performed in shielded room.

Measurement procedure was applied according to EN 61000-4-2 clause 8.

The test method and equipment were specified by EN 61000-4-2.

6.1.4. Test Results

PASS

Please refer to the following page.

No.	Location of discharge	Polarity	Discharge	Number of discharges	Test level kV	Result
1	HCP top side	P&N	C	25	4	PASS
3	HCP bottom side	P&N	C	25	4	PASS
5	VCP right side	P&N	C	25	4	PASS
7	VCP left side	P&N	C	25	4	PASS
9	Points on conductive surface	P&N	C	25	4	PASS
10	Points on non-conductive surface	P&N	A	10	8	PASS

HCP = Horizontal coupling plate VCP = Vertical coupling plate N = Negative P = Positive
A = Air discharge C = Contact discharge

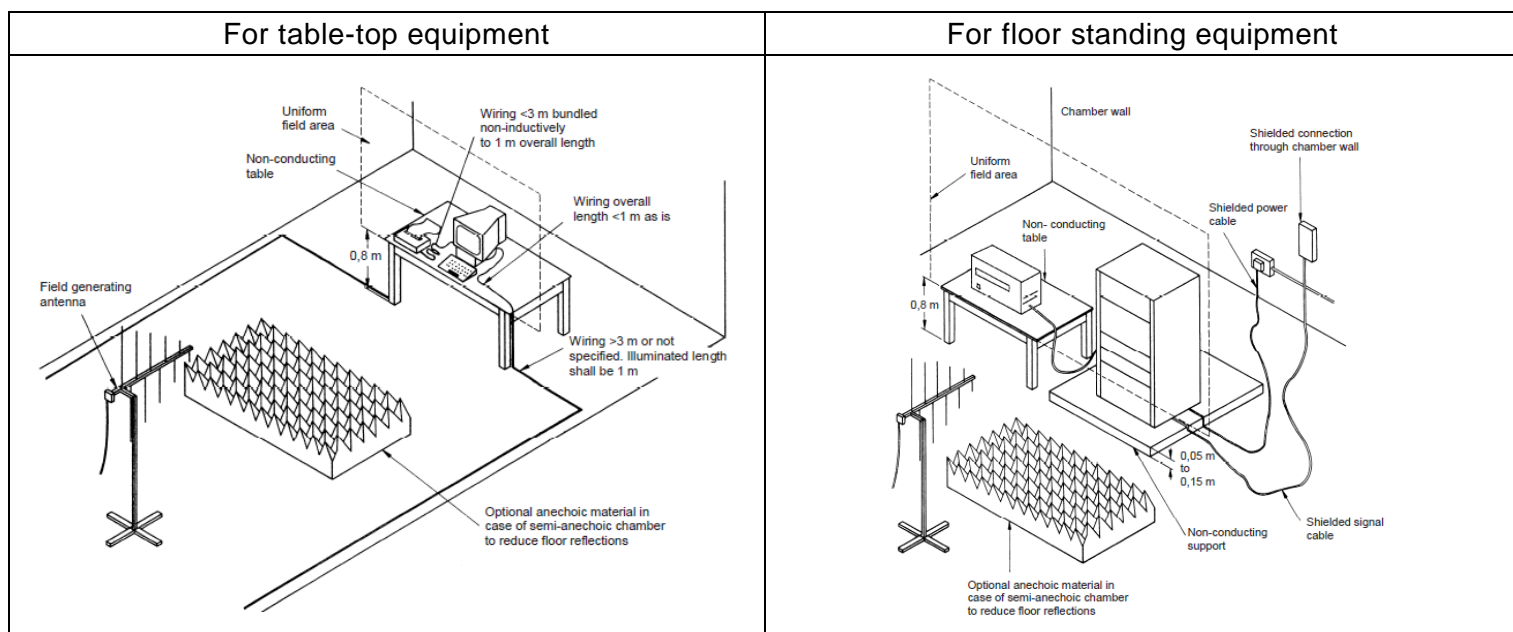
6.2. Radio-frequency electromagnetic field

6.2.1. Test Levels and Performance Criterion

Characteristics	Test levels
Frequency range	80 MHz to 1 000 MHz
Test level	3 V/m (unmodulated)
Modulation	1 kHz, 80 % AM, sine wave

Performance criterion: **A**

6.2.2. Test Setup



6.2.3. Test Procedure

Measurement was performed in full-anechoic chamber.

Measurement procedure was applied according to EN 61000-4-3 clause 8.

The test method and equipment was specified by EN 61000-4-3.

6.2.4. Test Results

PASS

Enclosure	Horizontal	Vertical
Front	PASS	PASS
Right Side	PASS	PASS
Left Side	PASS	PASS
Rear	PASS	PASS

6.3.Fast transients

6.3.1. Test Levels and Performance Criterion

Test levels at ports for signal and control lines

Characteristics	Test levels
Test level	± 0.5 kV (peak)
Rise time/hold time	5/50 ns
Repetition frequency	5 kHz
NOTE 1 Only applicable to ports interfacing with cables whose total length, according to the manufacturer's specification, may exceed 3 m.	
NOTE 2 Change of state commands are not applied during the test.	

Test levels at input and output d.c. power ports

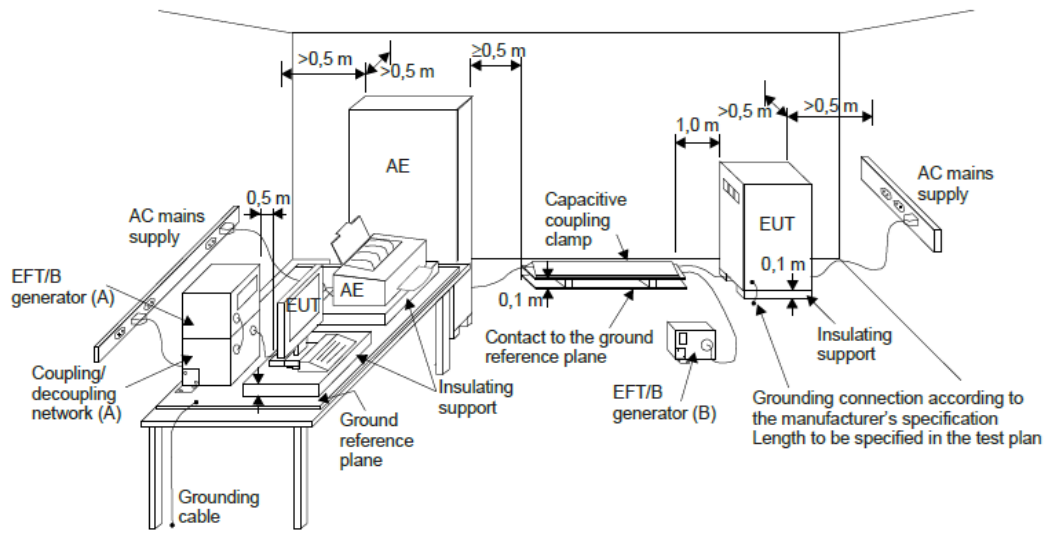
Characteristics	Test levels
Test level	± 0.5 kV (peak)
Rise time/hold time	5/50 ns
Repetition frequency	5 kHz
NOTE Not applicable to equipment not connected to the mains while in use.	

Test levels at input and output a.c. power ports

Characteristics	Test levels
Test level	± 1 kV (peak)
Rise time/hold time	5/50 ns
Repetition frequency	5 kHz

Performance criterion: **B**

6.3.2. Test Setup



6.3.3. Test Procedure

Measurement was performed in shielded room.

Measurement procedure was applied according to EN 61000-4-4 clause 8.

The test method and equipment was specified by EN 61000-4-4.

6.3.4. Test Results

PASS

Location	Level (kV)	Polarity (P/N)	Result
AC power ports	1	P/N	Pass
DC power ports	0,5	P/N	N/A
Signal and control lines	0,5	P/N	N/A

6.4. Injected currents (radio-frequency common mode)

6.4.1. Test Levels and Performance Criterion

Test levels at ports for signal and control lines

Characteristics	Test levels
Frequency range	0.15 MHz to 80 MHz
Test level	3 V r.m.s. (unmodulated)
Modulation	1 kHz, 80 % AM, sine wave
Source impedance	150 Ω
NOTE Only applicable to ports interfacing with cables whose total length, according to the manufacturer's specification, may exceed 3 m.	

Test levels at input and output d.c. power ports

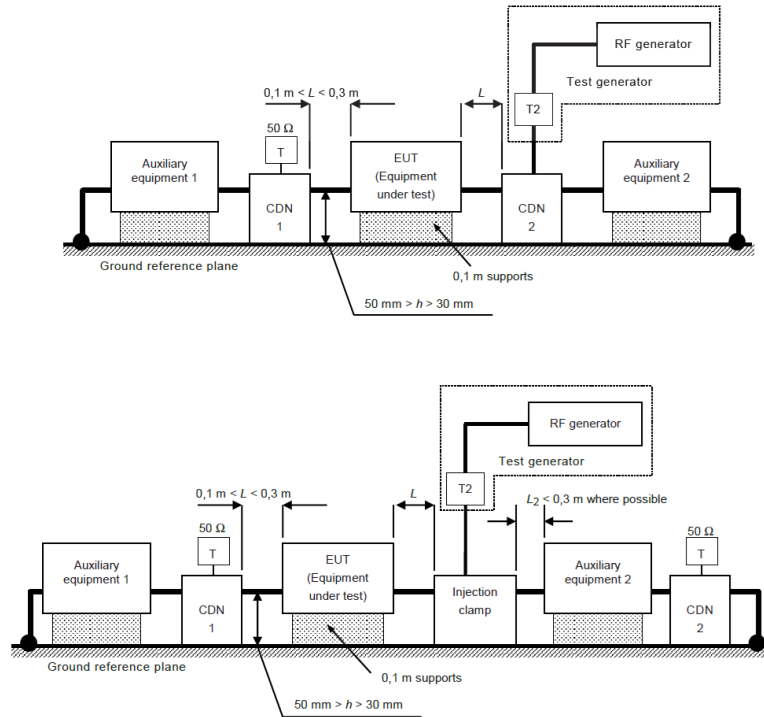
Characteristics	Test levels
Frequency range	0.15 MHz to 80 MHz
Test level	3 V r.m.s. (unmodulated)
Modulation	1 kHz, 80 % AM, sine wave
Source impedance	150 Ω
NOTE Only applicable to equipment that is connected to the mains while in use.	

Test levels at input and output a.c. power ports

Characteristics	Test levels
Frequency range	0.15 MHz to 80 MHz
Test level	3 V r.m.s. (unmodulated)
Modulation	1 kHz, 80 % AM, sine wave
Source impedance	150 Ω
NOTE Only applicable to ports interfacing with cables whose total length, according to the manufacturer's specification, may exceed 3 m.	

Performance criterion: **A**

6.4.2. Test Setup



6.4.3. Test Procedure

Measurement procedure was applied according to EN 61000-4-6 clause 8.

The test method and equipment was specified by EN 61000-4-6.

6.4.4. Test Results

PASS

Injected point	Frequency (MHz)	Level (e.m.f)	Modulation	Result
AC power ports	0.15 to 80	3V	80%, 1 kHz, AM	PASS
DC power ports	0.15 to 80	3V	80%, 1 kHz, AM	N/A
Signal and control lines	0.15 to 80	3V	80%, 1 kHz, AM	N/A

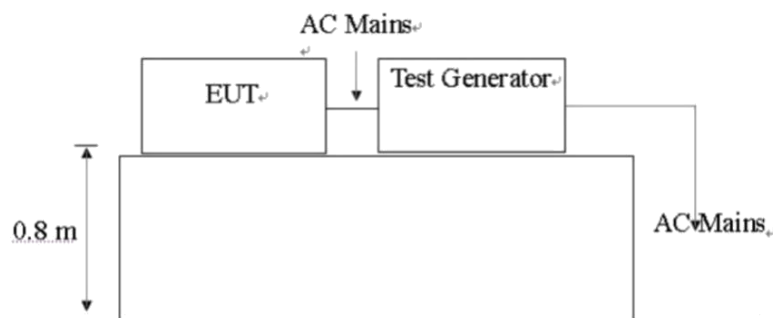
6.5. Surges

6.5.1. Test Levels and Performance Criterion

Characteristics		Test levels		
		Device		
		Self-ballasted lamps and semi-luminaires	Luminaires and independent auxiliaries	
			Input power	
Wave-shape data			≤25 W	>25 W
Test levels	line to line	±0.5 kV	±0.5 kV	±1.0 kV
	line to ground	±1.0 kV	±1.0 kV	±2.0 kV
NOTE In addition to the specified test level, all lower test levels as detailed in IEC 61000-4-5 should also be satisfied.				

Performance criterion: **B**

6.5.2. Test Setup



6.5.3. Test Procedure

Measurement was performed in shielded room.

Measurement procedure was applied according to EN 61000-4-5 clause 8.

The test method and equipment was specified by EN 61000-4-5.

6.5.4. Test Results

PASS

Please refer to the following page.

Location	Level(kV)	Polarity(P/N)	Result
Luminaires and independent auxiliaries >25 W (line to line)	1	P/N	Pass
Luminaires and independent auxiliaries >25 W (line to ground)	2	P/N	N/A
Luminaires and independent auxiliaries ≤25 W (line to line)	0,5	P/N	N/A
Luminaires and independent auxiliaries ≤25 W (line to ground)	1.0	P/N	N/A
Self-ballasted lamps and semi-luminaires (line to line)	0,5	P/N	N/A
Self-ballasted lamps and semi-luminaires (line to ground)	1.0	P/N	N/A

6.6. Voltage dips and Short interruptions

6.6.1. Test Levels and Performance Criterion

Voltage dips – Test levels at input a.c. power ports

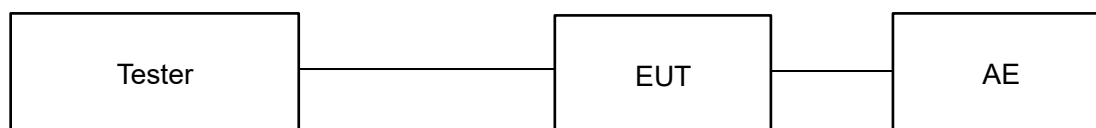
Characteristics	Test levels
Test voltage level	70 %
Number of periods	10

Voltage short interruptions – Test levels at input a.c. power ports

Characteristics	Test levels
Test voltage level	0 %
Number of periods	0.5

Performance criterion: **C & B**

6.6.2. Test Setup



6.6.3. Test Procedure

Measurement was performed in shielded room.

Measurement procedure was applied according to EN 61000-4-11 clause 8.

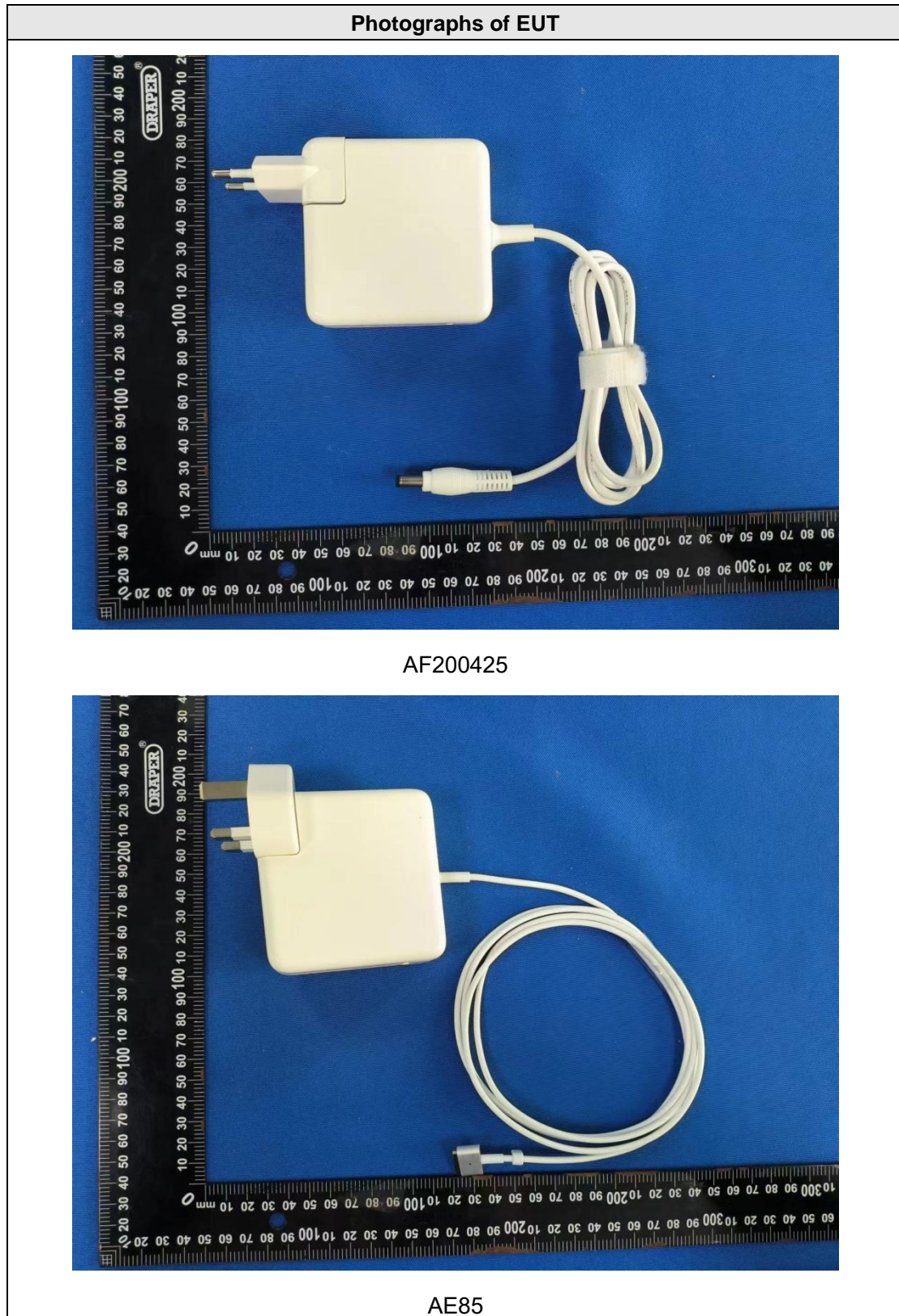
The test method and equipment was specified by EN 61000-4-11.

6.6.4. Test Results

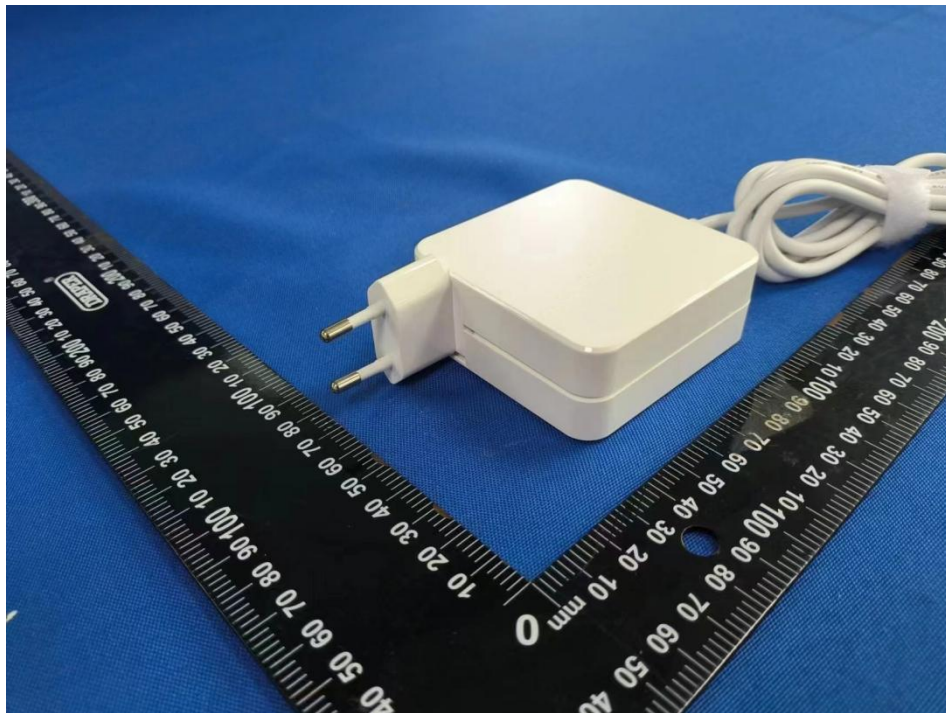
PASS

Test level %U _T	Voltage dips & short interruptions %U _T	Duration [Cycles]	Result
70	30	10	Pass
0	100	0.5	Pass
Remark: U _T is the rated voltage for the equipment.			

7. Photographs of EUT



Photographs of EUT - AE100-B



Photographs of EUT - AE100-B



----- End of Report -----